

Descriptions

This is N-Ch SiC Power MOSFET in a TO-3PF Plastic Package.

Features

- VDS=1700V
- ID=5A (Tc=25°C)
- RDS=710mΩ (VGS=15V,TJ=25°C)
- Low On-Resistance with High Blocking Voltage
- Low Capacitance
- Halogen Free, Rohs Compliant

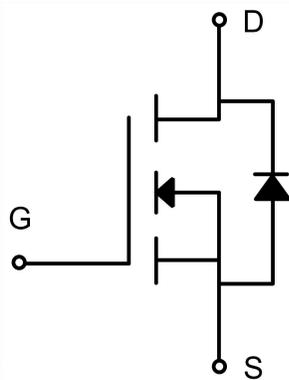
Applications

- Switch Mode Power Supplies (SMPS)
- Auxiliary power supplies
- High-voltage capacitive loads

Benefits

- High Frequency Operation
- Enabling Higher Switching Frequency
- Increased Power Density
- Reduction of Heat Sink Requirements

Schematic & PIN Configuration



TO-3PF

Maximum Rated Valued of MOSFET

Drain-source voltage	V_{DSS}		1700	V
Recommend Gate-Source Voltage	V_{GSop}		-5/12...15	V
Gate-Source Voltage	V_{GSmax}	AC($f > 1\text{KHz}$)	-10/25	V
Continuous drain current	I_D	$V_{GS}=15\text{V}$, $T_C=100^\circ\text{C}$	3.5	A
		$V_{GS}=15\text{V}$, $T_C=25^\circ\text{C}$	5	A
Pulsed drain current	I_{DM}	t_{Pulse} limited by T_{jmax}	12	A
Maximum power dissipation	P_{tot}	$T_C=25^\circ\text{C}$, $T_J=150^\circ\text{C}$	96	W
Operating Junction Temperature	T_j		-55~150	$^\circ\text{C}$
Storage Temperature	T_{stg}		-55~150	$^\circ\text{C}$

Thermal Characteristic

Thermal resistance, junction-to-case	$R_{\theta JC}$		1.3	$^\circ\text{C/W}$
Thermal resistance, junction-to-ambient	$R_{\theta JA}$		62.5	$^\circ\text{C/W}$

Electrical Characteristics of MOSFET

Drain-Source breakdown voltage	$V_{(BR)DS}$	$I_D=250\mu A, V_{GS}=0V$	$T_J=25^\circ C$	1700	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$I_D=5mA, V_{DS}=V_{GS}$	$T_J=25^\circ C$ $T_J=150^\circ C$	2.0 -	2.9 2.0	4.0 -	V
Zero gate voltage drain current	I_{DSS}	$V_{DS}=1700V, V_{GS}=0V$	$T_J=25^\circ C$	-	-	100	μA
Gate-Source leakage current	I_{GSSF}	$V_{DS}=0V, V_{GS}=20V$	$T_J=25^\circ C$	-	-	200	nA
	I_{GSSR}	$V_{DS}=0V, V_{GS}=-4V$	$T_J=25^\circ C$	-	-	-200	nA
Drain-Source On-State resistance	$R_{DS(ON)}$	$V_{GS}=15V, I_D=2A$	$T_J=25^\circ C$	-	710	850	m Ω
			$T_J=150^\circ C$	-	1010	-	m Ω
		$V_{GS}=12V, I_D=2A$	$T_J=25^\circ C$	-	1040	1200	m Ω
			$T_J=150^\circ C$	-	1230	-	m Ω
Transconductance	G_{fs}	$V_{DS}=20V, I_D=2A$	$T_J=25^\circ C$	-	7.3	-	S
Internal gate resistance	R_{Gint}	$f=1MHz, V_{AC}=25mV$	$T_J=25^\circ C$	-	20	-	Ω
Input capacitance	C_{iss}	$f=1MHz, V_{DS}=1000V, V_{GS}=0V, V_{AC}=25mV$	$T_J=25^\circ C$	-	380	-	pF
Output capacitance	C_{oss}		$T_J=25^\circ C$	-	14	-	pF
Reverse transfer capacitance	C_{rss}		$T_J=25^\circ C$	-	3.2	-	pF
Gate to source charge	Q_{GS}	$V_{DS}=800V, I_{DS}=2A, V_{GS}=-5V/20V$	$T_J=25^\circ C$	-	4.8	-	nC
Gate to drain charge	Q_{GD}		$T_J=25^\circ C$	-	5.6	-	nC
Total gate charge	Q_G		$T_J=25^\circ C$	-	13	-	nC
Turn-on delay time	$t_{d on}$	$V_{DS}=1200V, I_{DS}=2A, R_{G-ext}=2.5\Omega, V_{GS}=-5V/20V,$	$T_J=25^\circ C$	-	6	-	ns
Rise time	t_r		$T_J=25^\circ C$	-	9.5	-	ns
Turn-off delay time	$t_{d off}$		$T_J=25^\circ C$	-	14	-	ns
Fall time	t_f		$T_J=25^\circ C$	-	23	-	ns
Turn-on energy loss per pulse	E_{on}		$T_J=25^\circ C$	-	37	-	μJ
Turn-off energy loss per pulse	E_{off}		$T_J=25^\circ C$	-	15	-	μJ

Characteristics of Body Diode

Forward voltage	V_{SD}	$I_{SD}=1A, V_{GS}=-4V$	$T_J=25^\circ C$	-	3.5	-	V
Continuous diode forward current	I_S		$T_J=25^\circ C$	-	-	4	A
Peak reverse recovery current	I_{RM}	$V_R=1200V, I_{SD}=2A, V_{GS}=-5V, -di/dt=1200A/us$	$T_J=150^\circ C$	-	3.5	-	A
Reverse recovery time	t_{rr}		$T_J=150^\circ C$	-	22	-	ns
Recovery charge	Q_{rr}		$T_J=150^\circ C$	-	31	-	nC

Typical Characteristics

Fig.1 Typical Forward Output Characteristics at $T_J=25^\circ\text{C}$

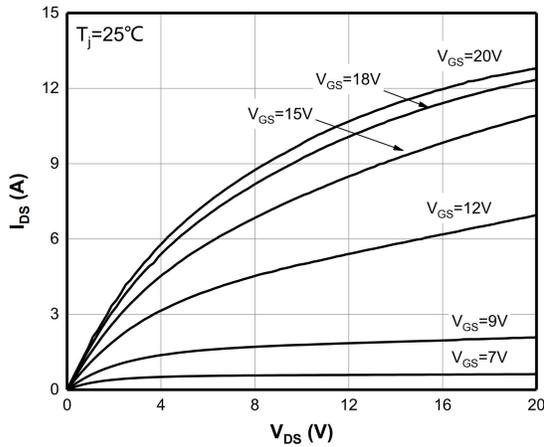


Fig.2 Typical Forward Output Characteristics at $T_J=150^\circ\text{C}$

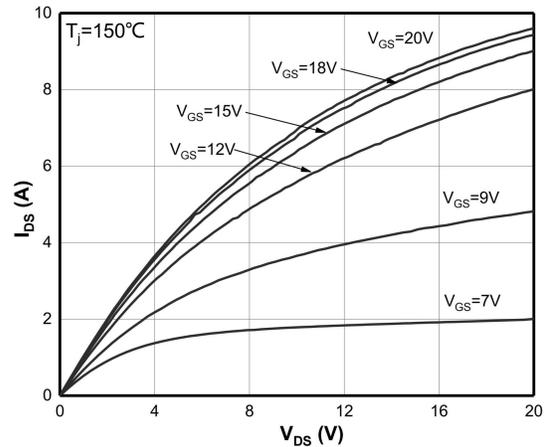


Fig.3 Transfer Characteristics for Various Temperature

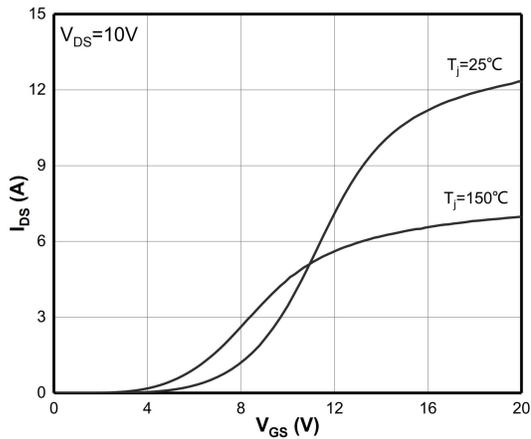


Fig.4 Threshold Voltage for Various Temperature

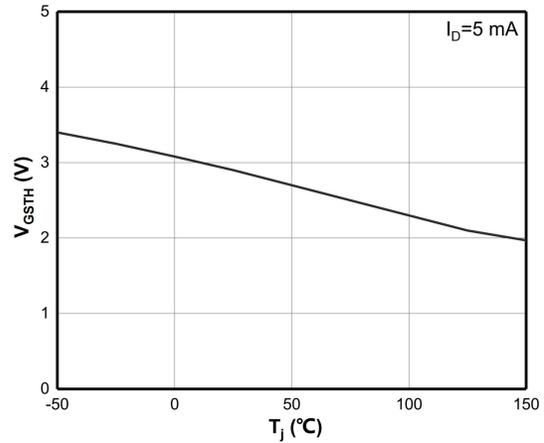


Fig.5 Normalized On-Resistance vs. Temperature for Various Gate Voltage

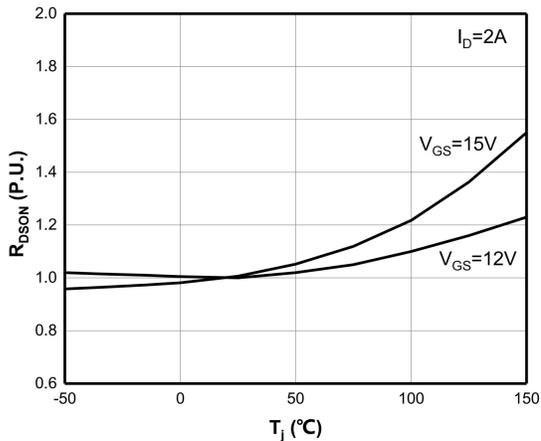
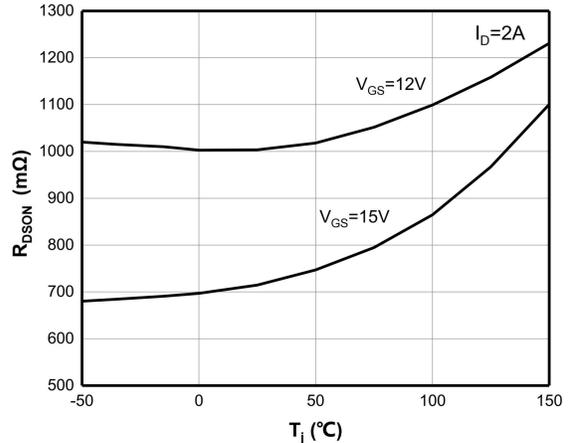


Fig.6 On-Resistance vs. Temperature for Various Gate Voltage



Typical Characteristics

Fig.7 Breakdown Voltage vs. Temperature

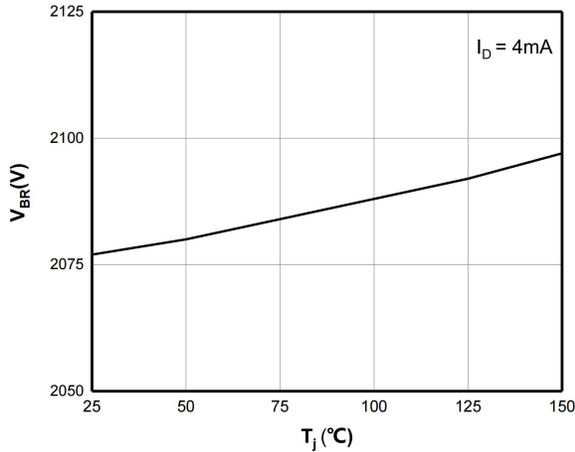


Fig.9 Capacitance vs. Drain-Source Voltage

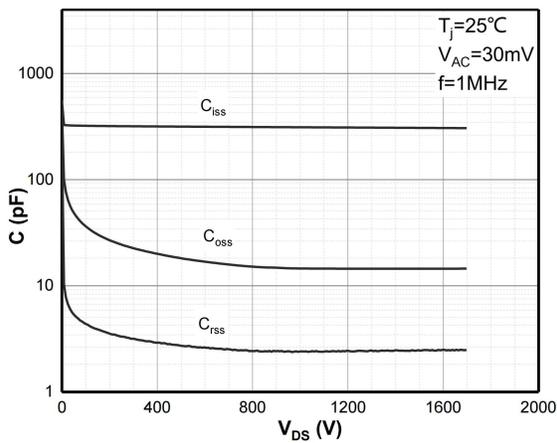


Fig.11 Continuous Drain Current Derating vs. Case Temperature

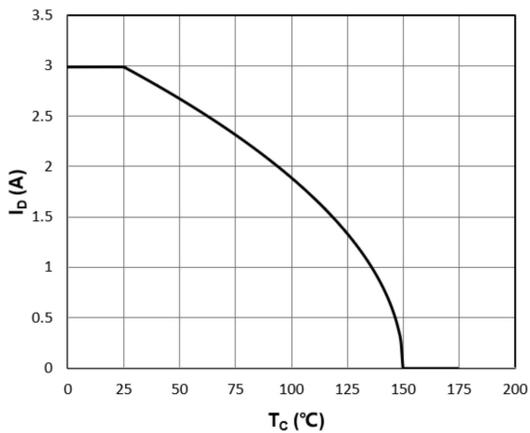


Fig.8 Body Diode Characteristics

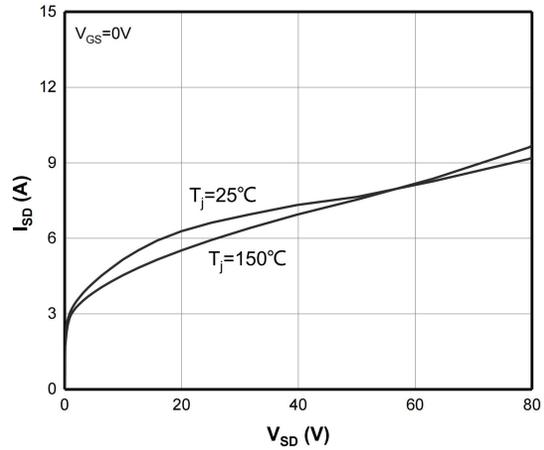


Fig.10 Gate Charge Characteristics

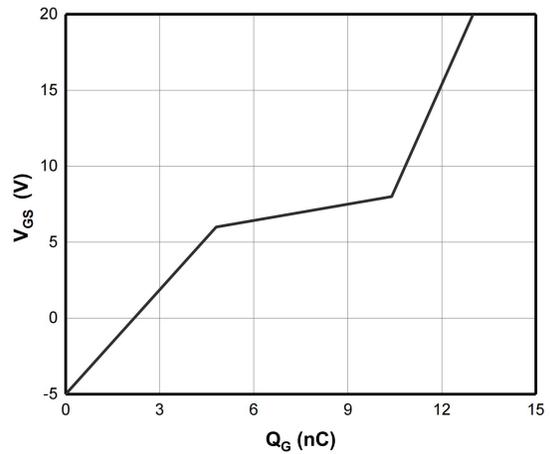
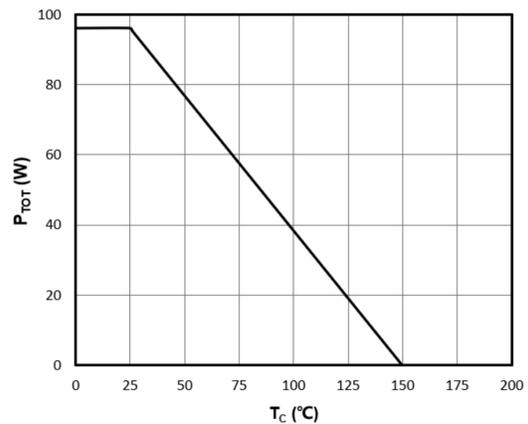


Fig.12 Power dissipation Derating vs. Case Temperature



Typical Characteristics

Fig.13 Clamped inductive switching energy vs. temperature

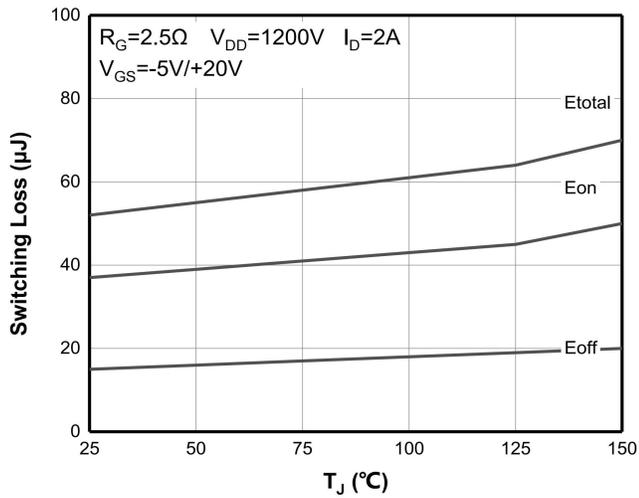


Fig.15 Safe Operating Area

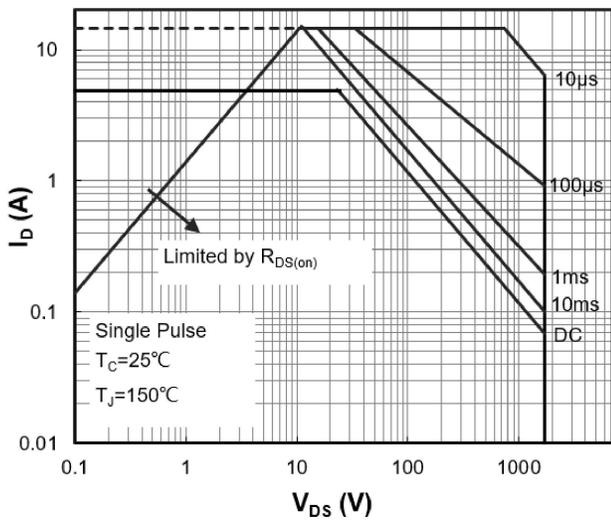


Fig.14 Clamped Inductive Switching Energy vs. External Gate Resistance

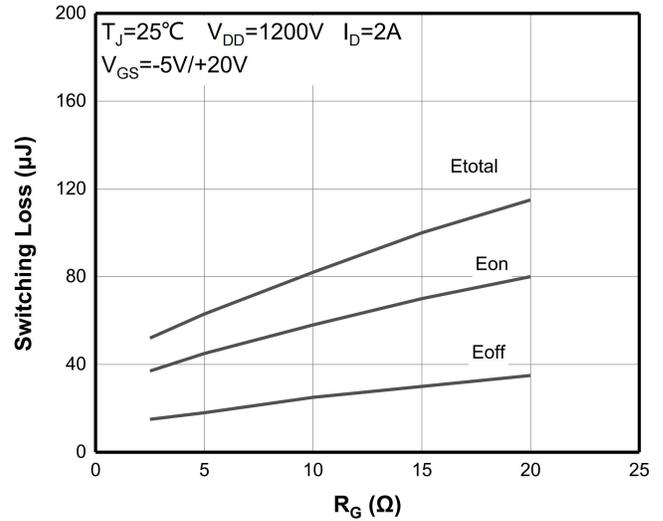
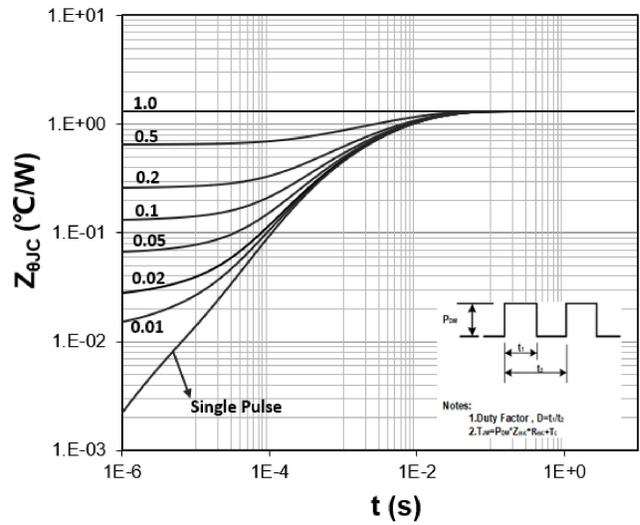


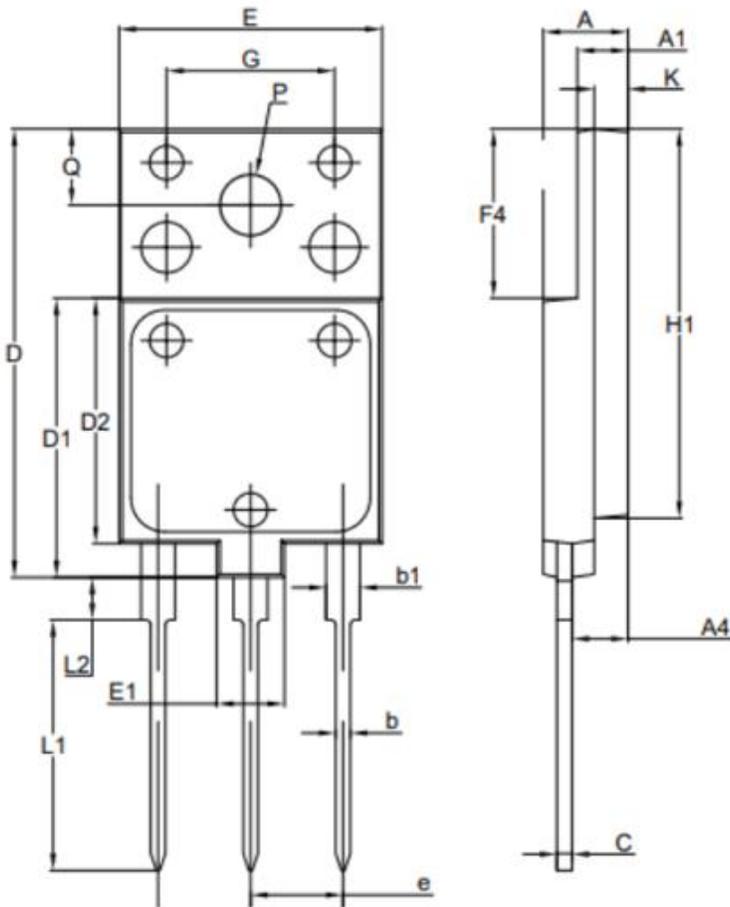
Fig.16 Transient Thermal Impedance (Junction – Case)



Ordering Information

Part	Package	Marking	Packing method
CTCM01KEA170T2C	TO-3PF	1KEA170T2C	Tube

Package Information



COMMON DIMENSIONS			
SYMBOL	MM		
	MIN	NOM	MAX
A	5.3	5.5	5.7
A1	2.8	3	3.2
b	0.66	0.86	1.06
b1	1.8	2	2.2
A4	3.1	3.3	3.5
C	0.8	0.9	1
D	26.3	26.5	26.7
D1	16.3	16.5	16.7
D2	14.3	14.5	14.7
P	3.4	3.6	3.8
E	15.3	15.5	15.7
E1	3.8	4	4.2
e	5.15	5.45	5.75
G	9.7	9.9	10.1
Q	4.35	4.5	4.65
L1	14.6	14.8	15
L2	2.3	2.5	2.7
K	1.8	2	2.2
F4	9.8	10	10.2
H1	22.8	23	23.2
K	1.8	2	2.2